

2.7. Test Photo

Test Mode : Mode 1:D-SUB (1024*768/75Hz), Adapter (LITE ON)

Description : Front View of Conducted Test -Mode1



Test Mode : Mode 1:D-SUB (1024*768/75Hz), Adapter (LITE ON)

Description : Back View of Conducted Test -Mode1



Test Mode : Mode 2:D-SUB (1024*768/75Hz), Adapter (LI SHIN)
Description : Front View of Conducted Test -Mode2



Test Mode : Mode 2:D-SUB (1024*768/75Hz), Adapter (LI SHIN)
Description : Back View of Conducted Test -Mode2



Test Mode : Mode 3:D-SUB (1024*768/75Hz), Adapter (HIPRO)
Description : Front View of Conducted Test -Mode3



Test Mode : Mode 3:D-SUB (1024*768/75Hz), Adapter (HIPRO)
Description : Back View of Conducted Test -Mode3



3.7. Test Photo

Test Mode : Mode 1:D-SUB (1024*768/75Hz), Adapter (LITE ON)

Description : Front View of Radiated Test -Mode1



Test Mode : Mode 1:D-SUB (1024*768/75Hz), Adapter (LITE ON)

Description : Back View of Radiated Test -Mode1



Test Mode : Mode 2:D-SUB (1024*768/75Hz), Adapter (LI SHIN)
 Description : Front View of Radiated Test -Mode2



Test Mode : Mode 2:D-SUB (1024*768/75Hz), Adapter (LI SHIN)
 Description : Back View of Radiated Test -Mode2



Test Mode : Mode 3:D-SUB (1024*768/75Hz), Adapter (HIPRO)
Description : Front View of Radiated Test -Mode3



Test Mode : Mode 3:D-SUB (1024*768/75Hz), Adapter (HIPRO)
Description : Back View of Radiated Test -Mode3

